Third edition 2014-12-01

Microscopes — Values, tolerances and symbols for magnification

Microscopes — Valeurs, tolérances et symboles de grossissement





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Published in Switzerland

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Foreword

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The committee responsible for this document is ISO/TC 172, *Optics and photonics*, Subcommittee SC 5, *Microscopes and endoscopes*.

This third edition cancels and replaces the second edition (ISO 8039:2012), of which it constitutes a minor revision.